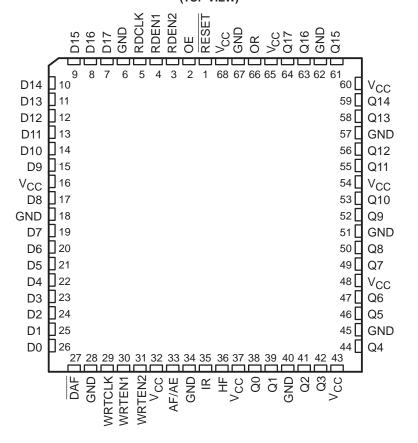
### **CLOCKED FIRST-IN, FIRST-OUT MEMORY**

SGAS004A - AUGUST 1995 - REVISED APRIL 1998

- **Member of the Texas Instruments** Widebus™ Family
- Independent Asynchronous Inputs and **Outputs**
- Read and Write Operations Can Be Synchronized to Independent System
- Programmable Almost-Full/Almost-Empty Flag
- Pin-to-Pin Compatible With SN74ACT7882, SN74ACT7884, and SN74ACT7811
- Input-Ready, Output-Ready, and Half-Full **Flags**

- Cascadable in Word Width and/or Word Depth
- Fast Access Times of 13 ns With a 50-pF Load
- **High Output Drive for Direct Bus Interface**
- Released as DSCC SMD (Standard Microcircuit Drawing) 5962-9562701QYA and 5962-9562701NXD
- Package Options Include 68-Pin Ceramic Quad Flat (HV) and 80-Pin Plastic Quad Flat (PN) Packages

#### **HV PACKAGE** (TOP VIEW)

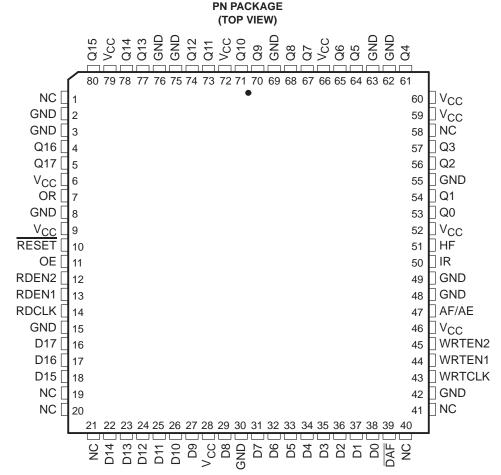




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Widebus is a trademark of Texas Instruments Incorporated





NC - No internal connection

### description

A FIFO memory is a storage device that allows data to be written into and read from its array at independent data rates. The SN54ACT7881 is organized as  $1024 \times 18$  bits and processes data with rates up to 50 MHz and access times of 13 ns in a bit-parallel format. Data outputs are noninverting with respect to the data inputs. Expansion is accomplished easily in both word width and word depth.

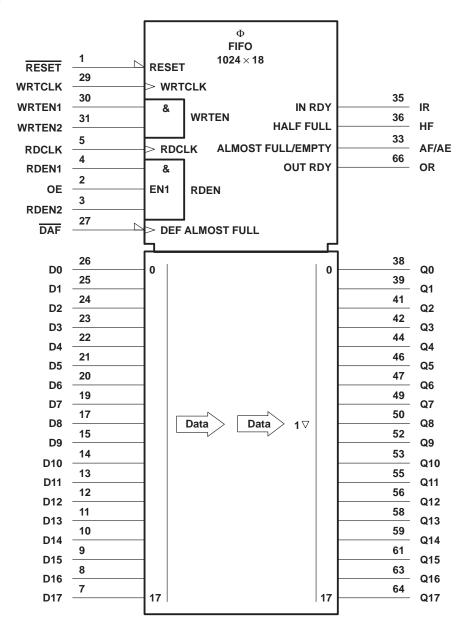
The SN54ACT7881 has normal input-bus to output-bus asynchronous operation. The special enable circuitry adds the ability to synchronize independent reads and writes to their respective system clocks.

The SN54ACT7881 is characterized for operation over the full military temperature range of -55°C to 125°C.



# CLOCKED FIRST-IN, FIRST-OUT MEMORY SGAS004A – AUGUST 1995 – REVISED APRIL 1998

### logic symbol†

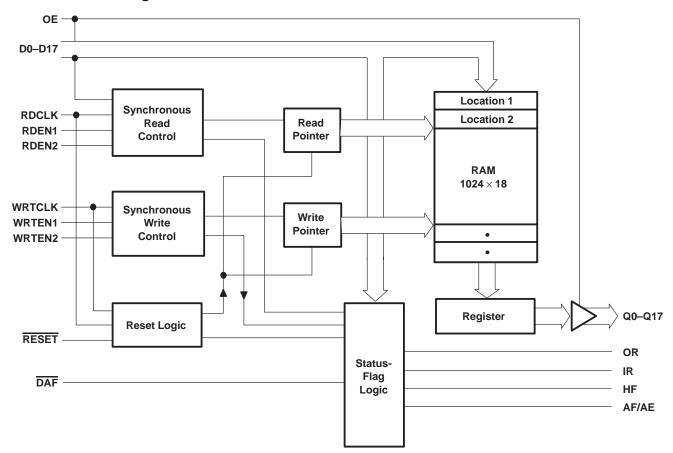


<sup>&</sup>lt;sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the HV package.



# CLOCKED FIRST-IN, FIRST-OUT MEMORY SGAS004A – AUGUST 1995 – REVISED APRIL 1998

### functional block diagram





# CLOCKED FIRST-IN, FIRST-OUT MEMORY SGAS004A – AUGUST 1995 – REVISED APRIL 1998

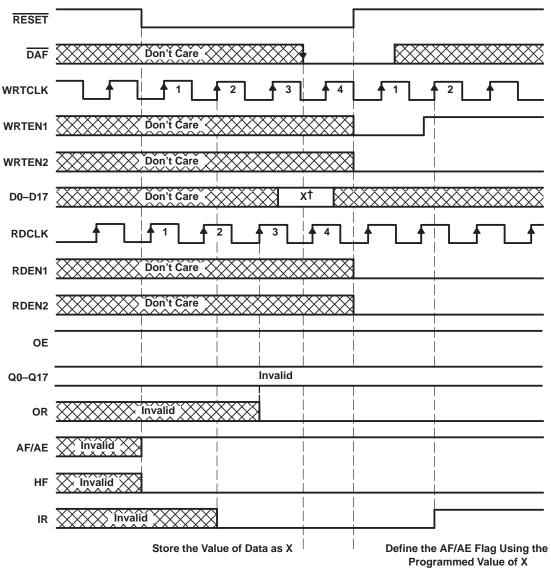
### **Terminal Functions**

TERMINAL <sup>†</sup>			PE00P:==::::
NAME	NO.	1/0	DESCRIPTION
AF/AE 47		0	Almost-full/almost-empty flag. The AF/AE boundary is defined by the AF/AE offset value (X). This value can be programmed during reset, or the default value of 256 can be used. AF/AE is high when the FIFO contains (X + 1) or fewer words or (1025 – X) or more words. AF/AE is low when the FIFO contains between (X + 2) and (1024 – X) words.  Programming procedure for AF/AE – The AF/AE flag is programmed during each reset cycle. The AF/AE offset value (X) is either a user-defined value or the default of X = 256. Instructions to program AF/AE using both methods are as follows:
			Step 1: Take DAF from high to low.  Step 2: If RESET is not already low, take RESET low.  Step 3: With DAF held low, take RESET high. This defines the AF/AE using X.  Step 4: To retain the current offset for the next reset, keep DAF low.  Default X  To redefine AF/AE using the default value of X = 256, hold DAF high during the reset cycle.
DAF	39	ı	Define-almost-full. The high-to-low transition of DAF stores the binary value of data inputs as the AF/AE offset value (X). With DAF held low, a low pulse on RESET defines the AF/AE flag using X.
D0-D17	18–16, 27–22, 29, 38–31	ı	Data inputs for 18-bit-wide data to be stored in the memory. A high-to-low transition of DAF captures data for the AF/AE offset (X) from D8–D0.
HF	51	0	Half-full flag. HF is high when the FIFO contains 512 or more words and is low when the number of words in memory is less than half the depth of the FIFO.
IR	50	0	Input-ready flag. IR is high when the FIFO is not full and low when the device is full. During reset, IR is driven low on the rising edge of the second WRTCLK pulse. IR is then driven high on the rising edge of the second WRTCLK pulse after RESET goes high. After the FIFO is filled and IR is driven low, IR is driven high on the second WRTCLK pulse after the first valid read.
OE	11	I	Output enable. The Q0–Q17 outputs are in the high-impedance state when OE is low. OE must be high before the rising edge of RDCLK to read a word from memory.
OR	7	0	Output-ready flag. OR is high when the FIFO is not empty and low when the FIFO is empty. During reset, OR is set low on the rising edge of the third RDCLK pulse. OR is set high on the rising edge of the third RDCLK pulse to occur after the first word is written into the FIFO. OR is set low on the rising edge of the first RDCLK pulse after the last word is read.
Q0-Q17	4, 5, 53, 54, 56, 57, 61, 64, 65, 67, 68, 70, 71, 73, 74, 77, 78, 80,	0	Data outputs. The first data word to be loaded into the FIFO is moved to Q0–Q17 on the rising edge of the third RDCLK pulse to occur after the first valid write. RDEN1 and RDEN2 do not affect this operation. Following data is unloaded on the rising edge of RDCLK when RDEN1, RDEN2, OE, and OR are high.
RDCLK	14	1	Read clock. Data is read out of memory on the low-to-high transition of RDCLK if OR, OE, RDEN1, and RDEN2 are high. RDCLK is a free-running clock and functions as the synchronizing clock for all data transfers out of the FIFO. OR also is driven synchronously with respect to RDCLK.
RDEN1 RDEN2	13 12	I	Read enable. RDEN1 and RDEN2 must be high before a rising edge on RDCLK to read a word out of memory. RDEN1 and RDEN2 are not used to read the first word stored in memory.
RESET	10	I	Reset. A reset is accomplished by taking RESET low and generating a minimum of four RDCLK and WRTCLK cycles. This ensures that the internal read and write pointers are reset and that OR, HF, and IR are low, and AF/AE is high. The FIFO must be reset upon power up. With DAF at a low level, a low pulse on RESET defines AF/AE using the AF/AE offset value (X), where X is the value previously stored. With DAF at a high level, a low-level pulse on RESET defines the AF/AE flag using the default value of X = 256.
WRTCLK	29	ı	Write clock. Data is written into memory on a low-to-high transition of WRTCLK if IR, WRTEN1, and WRTEN2 are high. WRTCLK is a free-running clock and functions as the synchronizing clock for all data transfers into the FIFO. IR also is driven synchronously with respect to WRTCLK.
WRTEN1 WRTEN2	30 31	ı	Write enable. WRTEN1 and WRTEN2 must be high before a rising edge on WRTCLK for a word to be written into memory. WRTEN1 and WRTEN2 do not affect the storage of the AF/AE offset value (X).

<sup>†</sup> Terminals listed are for the PN package.



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<sup>†</sup> X is the binary value on D8–D0.

Figure 1. Reset Cycle: Define AF/AE Flag Using a Programmed Value of X



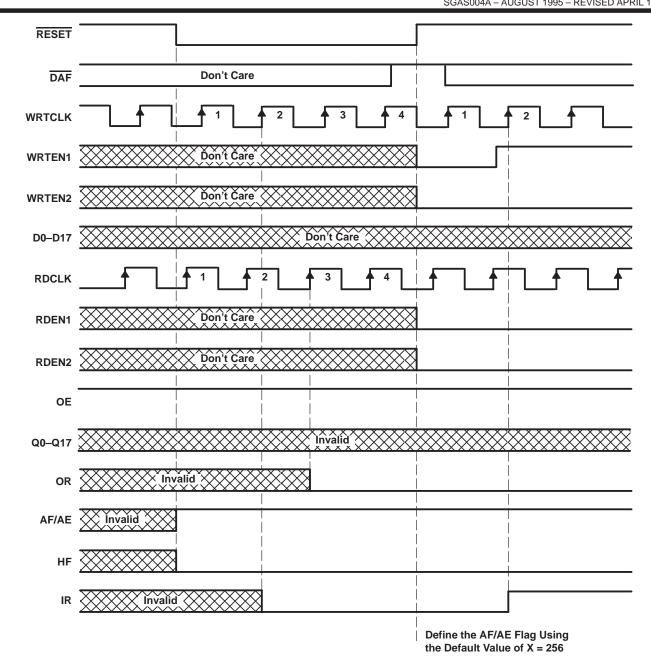
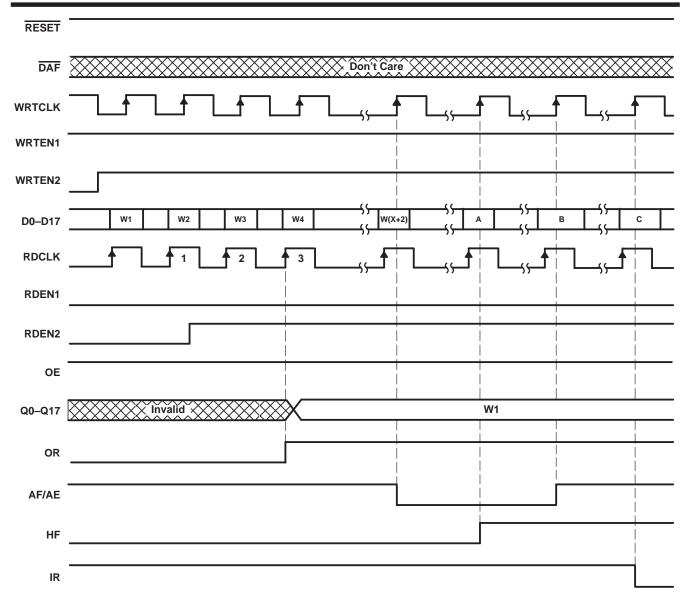


Figure 2. Reset Cycle: Define AF/AE Flag Using the Default Value of X = 256

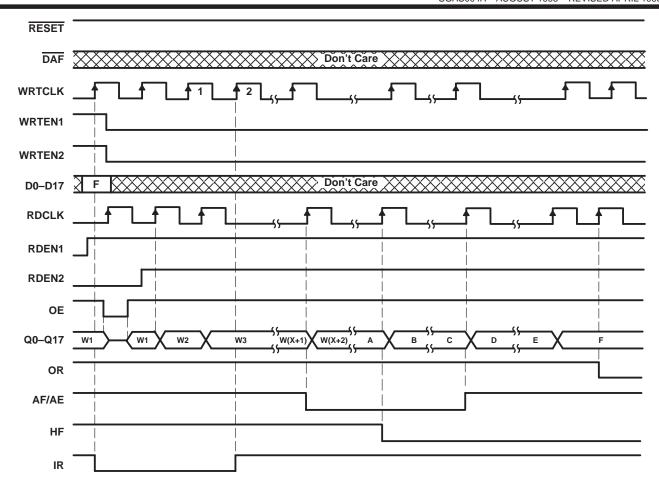


#### **DATA-WORD NUMBERS FOR FLAG TRANSITIONS**

TRANSITION WORD						
Α	В	С				
W513	W(1025 - X)	W1025				

Figure 3. Write Cycle





### **DATA-WORD NUMBERS FOR FLAG TRANSITIONS**

TRANSITION WORD							
A B C D E F							
W513	W514	W(1024 – X)	W(1025 - X)	W1024	W1025		

Figure 4. Read Cycle

### **CLOCKED FIRST-IN, FIRST-OUT MEMORY**

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### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

### recommended operating conditions

		MIN	MAX	UNIT
Vcc	Supply voltage	4.5	5.5	V
VIH	High-level input voltage	2		V
VIL	Low-level input voltage		0.8	V
ІОН	High-level output current		-8	mA
l <sub>OL</sub>	Low-level output current		16	mA
TA	Operating free-air temperature	-55	125	°C

### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TE	MIN	TYP <sup>‡</sup>	MAX	UNIT	
Voн	V <sub>CC</sub> = 4.5 V,	$I_{OH} = -8 \text{ mA}$	2.4			V
VoL	V <sub>CC</sub> = 4.5 V,	I <sub>OL</sub> = 16 mA			0.5	V
ΙĮ	V <sub>CC</sub> = 5.5 V,	$V_I = V_{CC}$ or 0			±5	μΑ
loz	V <sub>CC</sub> = 5.5 V,	VO = VCC or 0			±5	μΑ
. 8	$V_{I} = V_{CC} - 0.2 \text{ V or } 0$				400	μΑ
I <sub>CC</sub> §	One input at 3.4 V,	Other inputs at V <sub>CC</sub> or GND			1.2	mA
Ci	V <sub>I</sub> = 0,	f = 1 MHz		4		pF
Co	$V_{O} = 0$ ,	f = 1 MHz		8		pF

<sup>‡</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .



<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

<sup>§</sup> I<sub>CC</sub> is tested with outputs open.

## CLOCKED FIRST-IN, FIRST-OUT MEMORY SGAS004A – AUGUST 1995 – REVISED APRIL 1998

# timing requirements over recommended ranges of supply voltage and operating free-air temperature (see Figures 1 through 4)

			MIN	MAX	UNIT
fclock	Clock frequency			50	MHz
		WRTCLK high	7		
		WRTCLK low	7.5		
$t_W$	Pulse duration	RDCLK high	7		ns
		RDCLK low	7		
		DAF high	7		
		D0-D17 before WRTCLK↑	5		
		WRTEN1, WRTEN2 high before WRTCLK↑	5		
		OE, RDEN1, RDEN2 high before RDCLK↑	5		
t <sub>su</sub>	Setup time	Reset: RESET low before first WRTCLK↑ and RDCLK↑†	6*		ns
		Define AF/AE: D0–D8 before DAF↓	5		
		Define AF/AE: DAF↓ before RESET↑	6		
		Define AF/AE (default): DAF high before RESET↑	5		
		D0-D17 after WRTCLK↑	0		
		WRTEN1, WRTEN2 high after WRTCLK↑	0		
t <sub>h</sub> I		OE, RDEN1, RDEN2 high after RDCLK↑	0.5		
	Hold time	Reset: RESET low after fourth WRTCLK↑ and RDCLK↑†	0*		ns
		Define AF/AE: D0–D8 after DAF↓	1		
		Define AF/AE: DAF low after RESET↑	0		
		Define AF/AE (default): DAF high after RESET↑	0		

<sup>\*</sup> On products compliant to MIL-PRF-38535, this parameter is not production tested .

# switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L$ = 50 pF (unless otherwise noted) (see Figure 5)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	MAX	UNIT
fmax	WRTCLK or RDCLK		50		MHz
t <sub>pd</sub>	RDCLK↑	Any Q	3	13	ns
t <sub>pd</sub> ‡	RDCLK↑	Any Q			ns
	WRTCLK↑	IR	2	9.5	
<b>.</b> .	RDCLK↑	OR	2	9.5	ns
<sup>t</sup> pd	WRTCLK↑	AF/AE	6	19	115
	RDCLK <sup>↑</sup>	AF/AE		19	
t <sub>PLH</sub>	WRTCLK↑	HF	6	17	ns
<sup>t</sup> PHL	RDCLK <sup>↑</sup>	HF	6	17	ns
t <sub>PLH</sub>	RESET↓	AF/AE	3	17	ns
t <sub>PHL</sub>	RESET↓	HF	3	19	ns
t <sub>en</sub>	OE	Any Q	2	11	ns
<sup>t</sup> dis	t <sub>dis</sub> OE		2	14	ns

<sup>‡</sup> This parameter is measured with  $C_L = 30 \text{ pF}$  (see Figure 5).



 $<sup>\</sup>ensuremath{^{\dagger}}$  To permit the clock pulse to be utilized for reset purposes

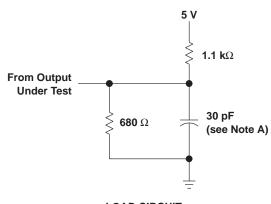
### CLOCKED FIRST-IN, FIRST-OUT MEMORY

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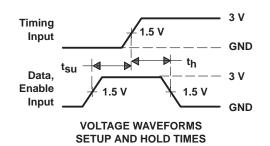
### operating characteristics, $V_{CC} = 5 \text{ V}$ , $T_A = 25^{\circ}\text{C}$

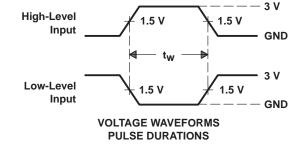
	PARAMETER	TEST CO	TYP	UNIT	
C <sub>pd</sub>	Power dissipation capacitance per 1K bits	$C_L = 50 pF$ ,	f = 5 MHz	65	pF

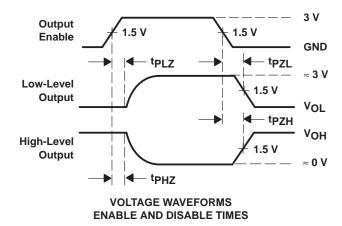
### PARAMETER MEASUREMENT INFORMATION

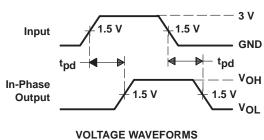


**LOAD CIRCUIT** 









**PROPAGATION DELAY TIMES** 

NOTES: A. Includes probe and jig capacitance

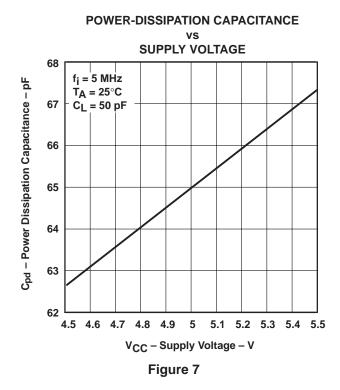
- B. tpzL and tpzH are the same as ten.
- C. tpLz and tpHz are the same as tdis.

Figure 5. Load Circuit and Voltage Waveforms



### **TYPICAL CHARACTERISTICS**

### PROPAGATION DELAY TIME **LOAD CAPACITANCE** 18 $V_{CC} = 5 V$ $R_L = 500 \Omega$ $T_A = 25^{\circ}C$ 17 t pd - Propagation Delay Time - ns 16 15 14 13 12 11 10 0 50 100 150 200 250 300 C<sub>L</sub> - Load Capacitance - pF Figure 6



#### APPLICATION INFORMATION

### expanding the SN54ACT7881

The SN54ACT7881 is expandable in both word width and word depth. Word-depth expansion is accomplished by connecting the devices in series such that data flows through each device in the chain. Figure 9 shows two SN54ACT7881 devices configured for word-depth expansion. The common clock between the devices can be tied to either the write clock (WRTCLK) of the first device or the read clock (RDCLK) of the last device. The output-ready flag (OR) of the previous device and the input-ready flag (IR) of the next device maintain data flow to the last device in the chain whenever space is available.

Figure 10 shows two SN54ACT7881 devices in word-width expansion. Word-width expansion is accomplished by simply connecting all common control signals between the devices and creating composite input-ready (IR) and output-ready (OR) signals. The almost-full/almost-empty flag (AF/AE) and half-full flag (HF) can be sampled from any one device. Word-depth expansion and word-width expansion can be used together.

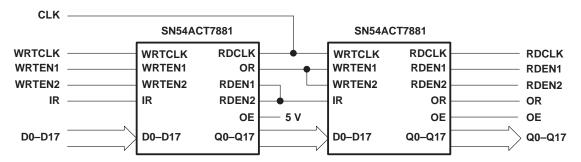


Figure 8. Word-Depth Expansion: 2048/4096/8192 Words  $\times$  18 Bits, N = 2

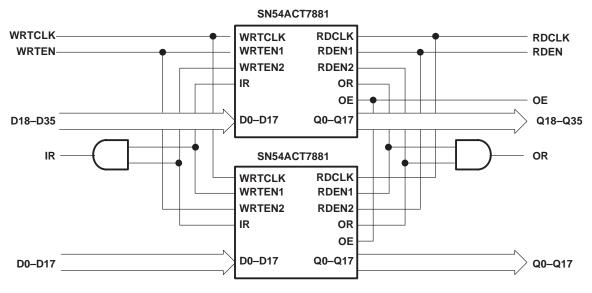


Figure 9. Word-Width Expansion: 1024 Words × 36 Bits







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#### PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing		ckage Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
5962-9562701NXD	ACTIVE	LQFP	PN	80	119	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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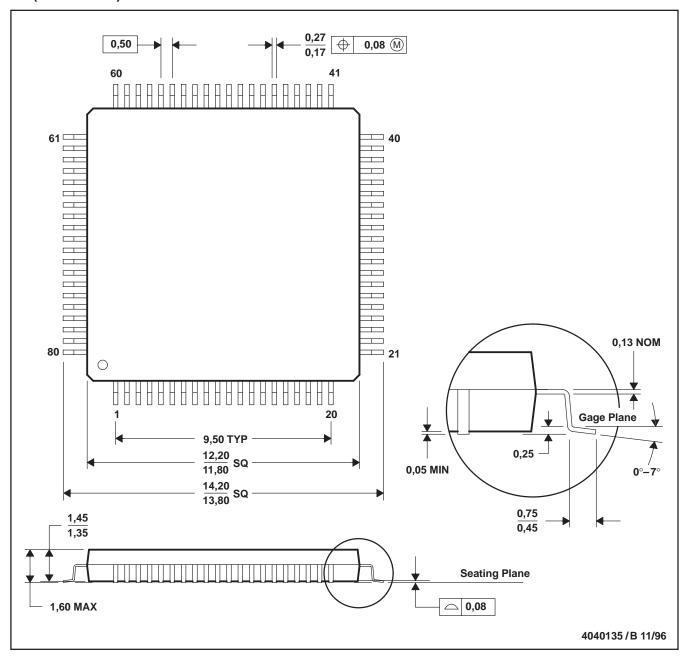
• Catalog: SN74ACT7881

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product

### PN (S-PQFP-G80)

### PLASTIC QUAD FLATPACK



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Falls within JEDEC MS-026

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